



RCE/1772 #

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Applicants: Lavada C. Boggs et al. Docket No.: 13,934.1
Serial No.: 09/689,048 Group: 1772
Filed: October 12, 2000 Examiner: William P. Watkins III
For: **REGIONALLY DISTINCT NONWOVEN WEBS**
Confirmation No.: 6114

Request for Continued Examination (RCE) Transmittal under 37 CFR § 1.114

Mail Stop RCE
Commissioner For Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

Applicants hereby request continued examination of the above-identified application in accordance with the provisions of 37 C.F.R. §1.114.

- a. ☐ Previously submitted
- I. ☐ Consider the amendment(s)/reply under 37 C.F.R. § 1.116 previously filed on
 - II. ☐ Consider the arguments in the Appeal Brief or Reply Brief previously filed on
 - III. ☐ Other
- b. ☒ Enclosed
- I. ☒ Amendment/Reply
 - II. ☐ Affidavit(s)/Declaration(s)
 - III. ☐ Information Disclosure Statement (IDS)
 - IV. ☒ Other (Petition for Three-Month Extension of Time)

Please charge the continuing examination fee of \$740.00 set forth in § 1.17(e) to Kimberly-Clark Worldwide, Inc. deposit account number 11-0875.

In the event the fee indicated above is incorrect, please charge any additional fee or credit any excess in the fee to Kimberly-Clark Worldwide, Inc. deposit account number 11-0875.

Please address all correspondence to: Christos S. Kyriakou, Kimberly-Clark Worldwide, Inc., 401 North Lake Street, Neenah, Wisconsin 54957-0349.

This request is submitted in duplicate.

The undersigned may be reached at telephone number (770) 587-8620 or fax number (770) 587-7327.

Respectfully submitted,

BOGGS ET AL.

By: Christos S. Kyriakou
Christos S. Kyriakou
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CERTIFICATE OF MAILING

I, Christos S. Kyriakou, hereby certify that on July 25, 2003 this document is being deposited with the United States Postal Service as first-class mail, postage prepaid, in an envelope addressed to: Mail Stop RCE Commissioner For Patents ; P.O. Box 1450; Alexandria, VA 22313-1450

By: Christos S. Kyriakou
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